

# 16-Mbit (2M words × 8 bit) Static RAM with Error-Correcting Code (ECC)

#### **Features**

- High speed□ t<sub>AA</sub> = 10 ns
- Embedded error-correcting code (ECC) for single-bit error correction
- Low active and standby currents
  □ I<sub>CC</sub> = 90 mA typical at 100 MHz
  □ I<sub>SB2</sub> = 20 mA typical
- Operating voltage range: 1.65 V to 2.2 V, 2.2 V to 3.6 V, 4.5 V to 5.5 V
- 1.0-V data retention
- Transistor-transistor logic (TTL) compatible inputs and outputs
- ERR pin to indicate 1-bit error detection and correction
- Available in Pb-free 54-pin TSOP II, and 48-ball VFBGA packages

#### **Functional Description**

The CY7C1069G and CY7C1069GE are dual chip enable high-performance CMOS fast static RAM devices with embedded ECC. The CY7C1069G device is available in standard pin configurations. The CY7C1069GE device includes a single bit error indication pin (ERR) that signals the host

processor in the case of an ECC error-detection and correction event

To write to the device, take Chip Enables ( $\overline{\text{CE}}_1$  LOW and CE<sub>2</sub> HIGH) and Write Enable ( $\overline{\text{WE}}$ ) input LOW. Data on the eight I/O pins (I/O<sub>0</sub> through I/O<sub>7</sub>) is then written into the location specified on the address pins (A<sub>0</sub> through A<sub>20</sub>).

To read from the device, take <u>Chip Enables</u> ( $\overline{CE}_1$  LOW and  $\overline{CE}_2$  HIGH) and Output Enable ( $\overline{OE}$ ) LOW while forcing the Write Enable ( $\overline{WE}$ ) HIGH. Under these conditions, the contents of the memory location specified by the address pins will appear on the I/O pins. See Truth Table – CY7C1069G/CY7C1069GE on page 14 for a complete description of Read and Write modes. The input and output pins (I/O<sub>0</sub> through I/O<sub>7</sub>) are placed in a high impedance state when the device is <u>de</u>selected ( $\overline{CE}_1$  HIGH or  $\overline{CE}_2$  LOW), the outputs are disabled ( $\overline{OE}$  HIGH), or during a write operation ( $\overline{CE}_1$  LOW,  $\overline{CE}_2$  HIGH, and  $\overline{WE}$  LOW).

On CY7C1069GE devices, the detection and correction of a single-bit error in the accessed location is indicated by the assertion of the ERR output (ERR = High) <sup>[1]</sup>.

All I/Os (I/O<sub>0</sub> through I/O<sub>7</sub>) are placed in a high impedance state when the device is deselected ( $\overline{\text{CE}}_1$  HIGH or  $\overline{\text{CE}}_2$  LOW), and control signals are de-asserted ( $\overline{\text{CE}}_1$  /  $\overline{\text{CE}}_2$ ,  $\overline{\text{OE}}$ , WE). CY7C1069G and CY7C1069GE devices are available in a 54-pin TSOP II package with center power and ground (revolutionary) pinout, and in a 48-ball VFBGA package.

For a complete list of related documentation, here.

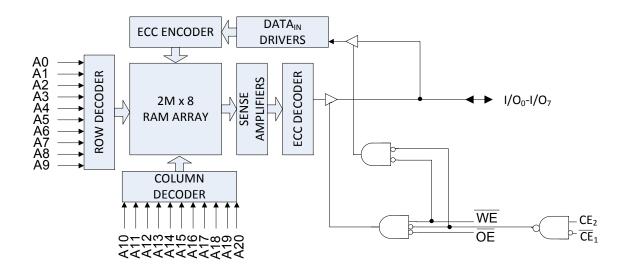
Note

Revised December 5, 2017

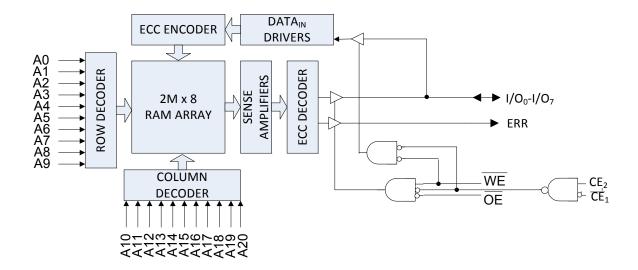
<sup>1.</sup> Automatic write back on error detection feature is not supported in this device.



# Logic Block Diagram - CY7C1069G



# Logic Block Diagram - CY7C1069GE





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# **Pin Configurations**

Figure 1. 54-pin TSOP II pinout (Top View) - CY7C1069G [2]

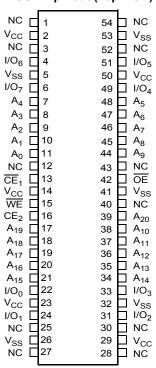
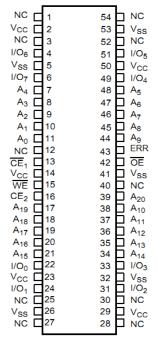


Figure 2. 54-pin TSOP II pinout (Top View) – CY7C1069GE [2, 3]



#### Note

- 2. NC pins are not connected on the die.
- 3. ERR is an Output pin. If not used, this pin should be left floating.



# Pin Configurations (continued)

Figure 3. 48-ball VFBGA pinout (Top View) – CY7C1069G [4]

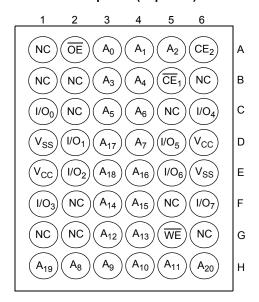
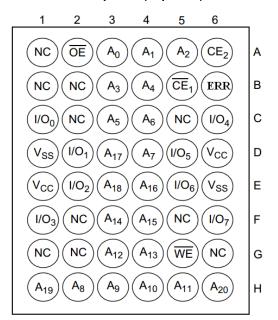


Figure 4. 48-ball VFBGA pinout (Top View) – CY7C1069GE [4, 5]



#### Note

- 4. NC pins are not connected on the die.5. ERR is an Output pin. If not used, this pin should be left floating.



# **Product Portfolio**

|              |                                   |            |                           |       | Power Dissipation    |                        |                                |     |
|--------------|-----------------------------------|------------|---------------------------|-------|----------------------|------------------------|--------------------------------|-----|
| Product      | Features and Options (see the Pin | Range      | V <sub>CC</sub> Range (V) | Speed | Operating            | I <sub>CC</sub> , (mA) | Standby I (mA)                 |     |
| Floudet      | Configurations section)           | Kange      | VCC Kange (V)             | (ns)  | f = f <sub>max</sub> |                        | Standby, I <sub>SB2</sub> (mA) |     |
|              |                                   |            |                           |       | Typ <sup>[6]</sup>   | Max                    | <b>Typ</b> <sup>[6]</sup>      | Max |
| CY7C1069G18  | Dual-chip enable                  | Industrial | 1.65 V-2.2 V              | 15    | 70                   | 80                     | 20                             | 30  |
| CY7C1069G30  |                                   |            | 2.2 V-3.6 V               | 10    | 90                   | 110                    |                                |     |
| CY7C1069G    |                                   |            | 4.5 V–5.5 V               | 10    | 90                   | 110                    |                                |     |
| CY7C1069GE18 | Dual-chip enable and ERR          |            | 1.65 V-2.2 V              | 15    | 70                   | 80                     |                                |     |
| CY7C1069GE30 | output                            |            | 2.2 V-3.6 V               | 10    | 90                   | 110                    |                                |     |
| CY7C1069GE   |                                   |            | 4.5 V–5.5 V               | 10    | 90                   | 110                    |                                |     |

<sup>6.</sup> Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V<sub>CC</sub> = 1.8 V (for V<sub>CC</sub> range of 1.65 V–2.2 V), V<sub>CC</sub> = 3 V (for V<sub>CC</sub> range of 2.2 V–3.6 V), and V<sub>CC</sub> = 5 V (for V<sub>CC</sub> range of 4.5 V–5.5 V), T<sub>A</sub> = 25 °C.



# **Maximum Ratings**

Exceeding maximum ratings may impair the useful life of the device. These user guidelines are not tested. Storage temperature ......-65 °C to +150 °C Ambient temperature with power applied ...... -55 °C to +125 °C Supply voltage on V<sub>CC</sub> relative to GND .....-0.5 V to +6.0 V DC voltage applied to outputs in High Z State  $^{[7]}$  ......–0.5 V to V $_{\rm CC}$  + 0.5 V

| DC input voltage [7]                                | 0.5 V to V <sub>CC</sub> + 0.5 V |
|---|----------------------------------|
| Current into outputs (LOW)                          | 20 mA                            |
| Static Discharge Voltage (MIL-STD-883, Method 3015) | >2001 V                          |
| Latch up current                                    | > 140 mA                         |

# **Operating Range**

| Grade      | Ambient Temperature | V <sub>CC</sub>                                       |
|------------|---------------------|---|
| Industrial | –40 °C to +85 °C    | 1.65 V to 2.2 V,<br>2.2 V to 3.6 V,<br>4.5 V to 5.5 V |

### **DC Electrical Characteristics**

Over the Operating Range of -40 °C to 85 °C

| Davamatav        | Description                                  |                        | Took Conditions   | 10                                   | ) ns / 15 n         | ıs                    | 11:::4 |  |
|------------------|--|------------------------|---|--------------------------------------|---------------------|-----------------------|--------|--|
| Parameter        | Desc   | cription               | Test Conditions   | Min                                  | Typ <sup>[8]</sup>  | Max                   | Unit   |  |
| V <sub>OH</sub>  | Output HIGH                                  | 1.65 V to 2.2 V        | V <sub>CC</sub> = Min, I <sub>OH</sub> = -0.1 mA  | 1.4                                  | _                   | _                     | V      |  |
|                  | voltage                                      | 2.2 V to 2.7 V         | V <sub>CC</sub> = Min, I <sub>OH</sub> = -1.0 mA  | 2.0                                  | _                   | _                     | Ī      |  |
|                  |  | 2.7 V to 3.0 V         | V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA  | 2.2                                  | _                   | -                     |        |  |
|                  |  | 3.0 V to 3.6 V         | V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA  | 2.4                                  | _                   | -                     | Ī      |  |
|                  |  | 4.5 V to 5.5 V         | V <sub>CC</sub> = Min, I <sub>OH</sub> = -4.0 mA  | 2.4                                  | _                   | -                     |        |  |
|                  |  | 4.5 V to 5.5 V         | V <sub>CC</sub> = Min, I <sub>OH</sub> = -0.1 mA  | V <sub>CC</sub> – 0.4 <sup>[9]</sup> | _                   | -                     |        |  |
| $V_{OL}$         | Output LOW                                   | 1.65 V to 2.2 V        | V <sub>CC</sub> = Min, I <sub>OL</sub> = 0.1 mA   | _                                    | _                   | 0.2                   | V      |  |
|                  | voltage                                      | 2.2 V to 2.7 V         | V <sub>CC</sub> = Min, I <sub>OL</sub> = 2 mA   | _                                    | _                   | 0.4                   |        |  |
|                  |  | 2.7 V to 3.6 V         | V <sub>CC</sub> = Min, I <sub>OL</sub> = 8 mA   | _                                    | _                   | 0.4                   |        |  |
|                  |  | 4.5 V to 5.5 V         | V <sub>CC</sub> = Min, I <sub>OL</sub> = 8 mA   | _                                    | _                   | 0.4                   | 1      |  |
| V <sub>IH</sub>  | Input HIGH                                   | 1.65 V to 2.2 V        | _   | 1.4                                  | _                   | V <sub>CC</sub> + 0.2 | V      |  |
|                  | voltage                                      | 2.2 V to 2.7 V         | _   | 2.0                                  | _                   | V <sub>CC</sub> + 0.3 |        |  |
|                  |  | 2.7 V to 3.6 V         | _   | 2.0                                  | _                   | V <sub>CC</sub> + 0.3 | Ī      |  |
|                  |  | 4.5 V to 5.5 V         | _   | 2.0                                  | _                   | V <sub>CC</sub> + 0.5 | Ī      |  |
| V <sub>IL</sub>  | Input LOW                                    | 1.65 V to 2.2 V        | _   | -0.2                                 | _                   | 0.4                   | V      |  |
|                  | voltage [7]                                  | 2.2 V to 2.7 V         | _   | -0.3                                 | _                   | 0.6                   | 1      |  |
|                  |  | 2.7 V to 3.6 V         | _   | -0.3                                 | _                   | 0.8                   | Ī      |  |
|                  |  | 4.5 V to 5.5 V         | _   | -0.5                                 | _                   | 0.8                   |        |  |
| I <sub>IX</sub>  | Input leakage c                              | urrent                 | $GND \le V_{IN} \le V_{CC}$   | -1.0                                 | _                   | +1.0                  | μΑ     |  |
| I <sub>OZ</sub>  | Output leakage                               | current                | GND ≤ V <sub>OUT</sub> ≤ V <sub>CC</sub> , Output disabled  | -1.0                                 | _                   | +1.0                  | μΑ     |  |
| I <sub>CC</sub>  | Operating supp                               | ly current             | V <sub>CC</sub> = Max, I <sub>OUT</sub> = 0 mA, f = 100 MHz<br>CMOS levels  | _                                    | 90.0                | 110.0                 | mA     |  |
|                  |  |                        | f = 66.7 MHz  | _                                    | 70.0                | 80.0                  | Ī      |  |
| I <sub>SB1</sub> | Automatic CE power down current – TTL inputs |                        | $\begin{aligned} &\text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{IH}}^{[10]}, \\ &\text{V}_{\text{IN}} \geq \text{V}_{\text{IH}} \text{ or V}_{\text{IN}} \leq \text{V}_{\text{IL}}, \text{ f = f}_{\text{MAX}} \end{aligned}$ | _                                    | _                   | 40.0                  | mA     |  |
| I <sub>SB2</sub> | Automatic CE p<br>current – CMO              | oower down<br>S inputs | $\begin{array}{l} \text{Max V}_{\text{CC}}, \overline{\text{CE}} \geq \text{V}_{\text{CC}} - 0.2 \text{ V}^{[10]}, \\ \text{V}_{\text{IN}} \geq \text{V}_{\text{CC}} - 0.2 \text{ V or V}_{\text{IN}} \leq 0.2 \text{ V, f} = 0 \end{array}$        | _                                    | 20.0 <sup>[8]</sup> | 30.0                  | mA     |  |

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<sup>7.</sup> V<sub>IL(min)</sub> = -2.0 V and V<sub>IH(max)</sub> = V<sub>CC</sub> + 2 V for pulse durations of less than 20 ns.

8. Typical values are included for reference only and are not guaranteed or tested. Typical values are measured at V<sub>CC</sub> = 1.8 V (for V<sub>CC</sub> range of 1.65 V–2.2 V), V<sub>CC</sub> = 3 V (for V<sub>CC</sub> range of 2.2 V–3.6 V), and V<sub>CC</sub> = 5 V (for V<sub>CC</sub> range of 4.5 V–5.5 V), T<sub>A</sub> = 25 °C.

9. This parameter is guaranteed by design and is not tested.

10. <u>For</u> all dual chip enable devices, <del>CE</del> is the logical combination of <del>CE</del> and <del>C</del>



# Capacitance

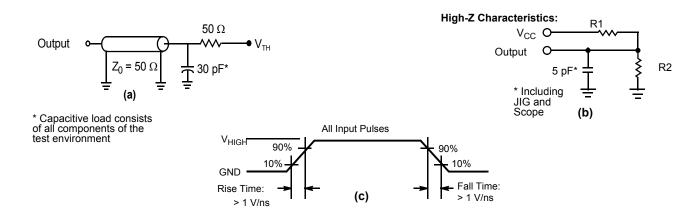
| Parameter [11]   | Description       | Test Conditions   |    | 48-ball VFBGA | Unit |
|------------------|-------------------|---|----|---------------|------|
| C <sub>IN</sub>  | Input capacitance | $T_A = 25 ^{\circ}\text{C}, f = 1 \text{MHz}, V_{CC} = V_{CC(typ)}$ | 10 | 10            | pF   |
| C <sub>OUT</sub> | I/O capacitance   |   | 10 | 10            | pF   |

# **Thermal Resistance**

| Parameter [11]    | Description                           | Test Conditions   | 54-pin TSOP II | 48-ball VFBGA | Unit |
|-------------------|---------------------------------------|---|----------------|---------------|------|
| $\Theta_{\sf JA}$ |                                       | Still air, soldered on a 3 × 4.5 inch, four-layer printed circuit board | 93.63          | 31.50         | °C/W |
| $\Theta_{\sf JC}$ | Thermal resistance (junction to case) |   | 21.58          | 15.75         | °C/W |

#### **AC Test Loads and Waveforms**

Figure 5. AC Test Loads and Waveforms [12]



| Parameters        | 1.8 V | 3.0 V | 5.0 V | Unit |
|-------------------|-------|-------|-------|------|
| R1                | 1667  | 317   | 317   | Ω    |
| R2                | 1538  | 351   | 351   | Ω    |
| $V_{TH}$          | 0.9   | 1.5   | 1.5   | V    |
| V <sub>HIGH</sub> | 1.8   | 3     | 3     | V    |

<sup>11.</sup> Tested initially and after any design or process changes that may affect these parameters.

<sup>12.</sup> Full device AC operation assumes a 100- $\mu$ s ramp time from 0 to  $V_{CC}$ (min) and 100- $\mu$ s wait time after  $V_{CC}$  stabilization.



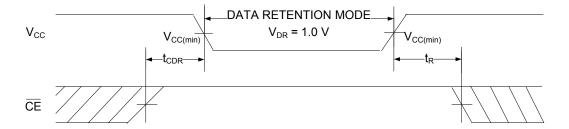
#### **Data Retention Characteristics**

Over the Operating Range of -40 °C to 85 °C

| Parameter                          | Description                          | Conditions  | Min  | Max  | Unit |
|------------------------------------|--------------------------------------|---|------|------|------|
| $V_{DR}$                           | V <sub>CC</sub> for data retention   | _   | 1.0  | -    | V    |
| I <sub>CCDR</sub>                  | Data retention current               | $V_{CC} = V_{DR}, \overline{CE} \ge V_{CC} - 0.2 \text{ V}^{[13]},$<br>$V_{IN} \ge V_{CC} - 0.2 \text{ V or } V_{IN} \le 0.2 \text{ V}$ | _    | 30.0 | mA   |
| t <sub>CDR</sub> <sup>[14]</sup>   | Chip deselect to data retention time | -   | 0    | -    | ns   |
| t <sub>R</sub> <sup>[14, 15]</sup> | Operation recovery time              | V <sub>CC</sub> ≥ 2.2 V   | 10.0 | ı    | ns   |
|                                    |                                      | V <sub>CC</sub> < 2.2 V   | 15.0 | -    | ns   |

# **Data Retention Waveform**

Figure 6. Data Retention Waveform [13]



<sup>13.</sup> For all dual chip enable devices, CE is the logical combination of CE<sub>1</sub> and CE<sub>2</sub>. When CE<sub>1</sub> is LOW and CE<sub>2</sub> is HIGH, CE is LOW; when CE<sub>1</sub> is HIGH or CE<sub>2</sub> is LOW, CE is HIGH.

 <sup>14.</sup> This parameter is guaranteed by design and is not tested.
 15. Full device operation requires linear V<sub>CC</sub> ramp from V<sub>DR</sub> to V<sub>CC(min.)</sub> ≥ 100 μs or stable at V<sub>CC(min.)</sub> ≥ 100 μs.



### **AC Switching Characteristics**

Over the Operating Range of -40 °C to 85 °C

| Parameter [16]     | Description  | 10       | ns   | 15 ns |      | 1114 |
|--------------------|--|----------|------|-------|------|------|
| Parameter [10]     | Description  | Min      | Max  | Min   | Max  | Unit |
| Read Cycle         |  |          | •    | •     | •    |      |
| t <sub>POWER</sub> | V <sub>CC</sub> stable to first access <sup>[17, 18]</sup> | 100.0    | _    | 100.0 | _    | μS   |
| t <sub>RC</sub>    | Read cycle time  | 10.0     | -    | 15.0  | -    | ns   |
| t <sub>AA</sub>    | Address to data / ERR valid                                | _        | 10.0 | -     | 15.0 | ns   |
| t <sub>OHA</sub>   | Data / ERR hold from address change                        | 3.0      | -    | 3.0   | _    | ns   |
| t <sub>ACE</sub>   | CE LOW to data / ERR valid [19]                            | _        | 10.0 | -     | 15.0 | ns   |
| t <sub>DOE</sub>   | OE LOW to data / ERR valid                                 | _        | 5.0  | _     | 8.0  | ns   |
| t <sub>LZOE</sub>  | OE LOW to low Z [20, 21, 22]                               | 0        | -    | 1.0   | -    | ns   |
| t <sub>HZOE</sub>  | OE HIGH to high Z [20, 21, 22]                             | _        | 5.0  | _     | 8.0  | ns   |
| t <sub>LZCE</sub>  | CE LOW to low Z [19, 20, 21, 22]                           | 3.0      | _    | 3.0   | _    | ns   |
| t <sub>HZCE</sub>  | CE HIGH to high Z [19, 20, 21, 22]                         | _        | 5.0  | _     | 8.0  | ns   |
| t <sub>PU</sub>    | CE LOW to power-up [18, 19]                                | 0        | _    | 0     | _    | ns   |
| t <sub>PD</sub>    | CE HIGH to power-down [18, 19]                             | _        | 10.0 | _     | 15.0 | ns   |
| Write Cycle [2     | 3, 24]   | <u> </u> |      |       |      |      |
| t <sub>WC</sub>    | Write cycle time   | 10.0     | _    | 15.0  | _    | ns   |
| t <sub>SCE</sub>   | CE LOW to write end [19]                                   | 7.0      | _    | 12.0  | _    | ns   |
| t <sub>AW</sub>    | Address setup to write end                                 | 7.0      | _    | 12.0  | _    | ns   |
| t <sub>HA</sub>    | Address hold from write end                                | 0        | _    | 0     | _    | ns   |
| t <sub>SA</sub>    | Address setup to write start                               | 0        | _    | 0     | _    | ns   |
| t <sub>PWE</sub>   | WE pulse width   | 7.0      | _    | 12.0  | _    | ns   |
| t <sub>SD</sub>    | Data setup to write end                                    | 5.0      | _    | 8.0   | _    | ns   |
| t <sub>HD</sub>    | Data hold from write end                                   | 0        | _    | 0     | _    | ns   |
| t <sub>LZWE</sub>  | WE HIGH to low Z [20, 21, 22]                              | 3.0      | _    | 3.0   | _    | ns   |
| t <sub>HZWE</sub>  | WE LOW to high Z [20, 21, 22]                              | _        | 5.0  | _     | 8.0  | ns   |

#### Notes

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<sup>16.</sup> Test conditions assume signal transition time (rise/fall) of 3 ns or less, timing reference levels of 1.5 V (for V<sub>CC</sub> ≥ 3 V) and V<sub>CC</sub>/2 (for V<sub>CC</sub> < 3 V), and input pulse levels of 0 to 3 V (for V<sub>CC</sub> ≥ 3 V) and 0 to V<sub>CC</sub> (for V<sub>CC</sub> < 3V). Test conditions for the read cycle use output loading shown in part (a) of Figure 5 on page 8, unless specified otherwise.

 $<sup>17.\,</sup>t_{POWER}\,\text{gives minimum amount of time that the power supply is at stable}\,\,V_{CC}\,\,\text{until first memory access is performed}.$ 

<sup>18.</sup> These parameters are guaranteed by design and are not tested.

<sup>19.</sup> For all dual chip enable devices,  $\overline{CE}$  is the logical combination of  $\overline{CE}_1$  and  $\overline{CE}_2$ . When  $\overline{CE}_1$  is LOW and  $\overline{CE}_2$  is HIGH,  $\overline{CE}$  is LOW; when  $\overline{CE}_1$  is HIGH or  $\overline{CE}_2$  is LOW,  $\overline{CE}$  is HIGH.

 $<sup>20.\</sup> t_{HZOE},\ t_{HZNE},\ t_{LZOE},\ t_{LZOE},\ t_{LZOE},\ and\ t_{LZWE}\ are\ specified\ with\ a\ load\ capacitance\ of\ 5\ pF\ as\ in\ (b)\ of\ Figure\ 5\ on\ page\ 8.\ Transition\ is\ measured\ \pm200\ mV\ from\ steady\ state\ voltage.$ 

<sup>21.</sup> At any temperature and voltage condition,  $t_{HZCE}$  is less than  $t_{LZCE}$ ,  $t_{HZBE}$  is less than  $t_{LZOE}$ ,  $t_{HZOE}$  is less than  $t_{LZOE}$ , and  $t_{HZWE}$  is less than  $t_{LZWE}$  for any device.

<sup>22.</sup> Tested initially and after any design or process changes that may affect these parameters.

<sup>23.</sup> The internal write time of the memory is defined by the overlap of  $\overline{WE} = V_{\parallel}$ ,  $\overline{CE} = V_{\parallel}$ . These signals must be LOW to initiate a write, and the HIGH transition of any of these signals can terminate the operation. The input data setup and hold timing should be referenced to the edge of the signal that terminates the write.

<sup>24.</sup> The minimum write pulse width for write cycle No.2 ( $\overline{\text{WE}}$  Controlled,  $\overline{\text{OE}}$  LOW) should be sum of  $t_{\text{HZWE}}$  and  $t_{\text{SD}}$ .



# **Switching Waveforms**

Figure 7. Read Cycle No. 1 of CY7C1069G (Address Transition Controlled)  $^{[25,\,26]}$ 

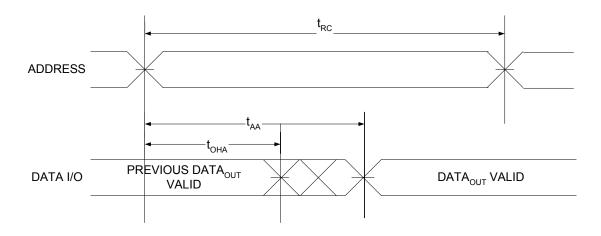
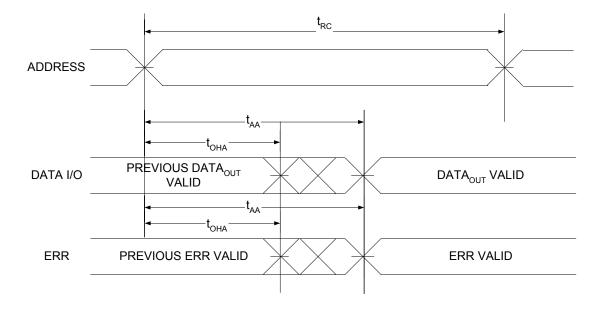


Figure 8. Read Cycle No. 2 of CY7C1069GE (Address Transition Controlled)  $^{[25,\ 26]}$ 

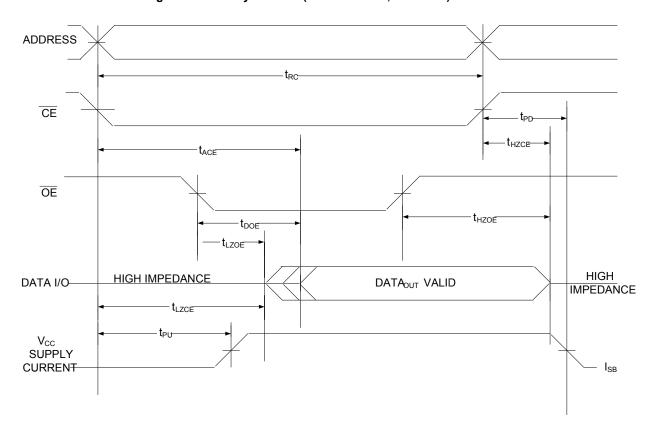


<sup>25.</sup> The device is continuously selected,  $\overline{OE}$  =  $V_{IL}$ ,  $\overline{CE}$  =  $V_{IL}$ . 26.  $\overline{WE}$  is HIGH for read cycle.



# Switching Waveforms (continued)

Figure 9. Read Cycle No. 3 (OE Controlled, WE HIGH) [27, 28, 29]



<sup>27.</sup>  $\underline{\text{For}}$  all dual chip enable devices,  $\overline{\text{CE}}$  is the logical combination of  $\overline{\text{CE}}_1$  and  $\overline{\text{CE}}_2$ . When  $\overline{\text{CE}}_1$  is LOW and  $\overline{\text{CE}}_2$  is HIGH,  $\overline{\text{CE}}$  is LOW; when  $\overline{\text{CE}}_1$  is HIGH or  $\overline{\text{CE}}_2$  is LOW,  $\overline{\text{CE}}$  is HIGH.

<sup>28.</sup>  $\overline{\text{WE}}$  is HIGH for read cycle.

<sup>29.</sup> Address valid prior to or coincident with  $\overline{\text{CE}}$  LOW transition.



# Switching Waveforms (continued)

Figure 10. Write Cycle No. 1 ( $\overline{\text{CE}}$  Controlled)  $^{[30,\ 31,\ 32]}$ 

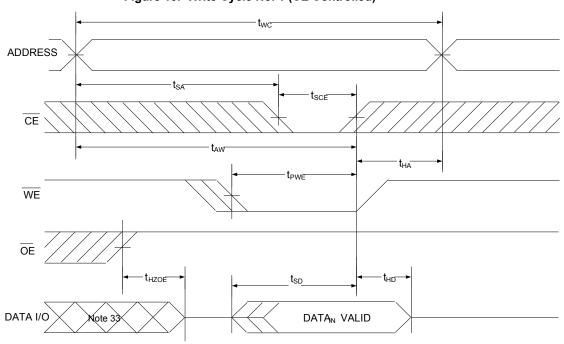
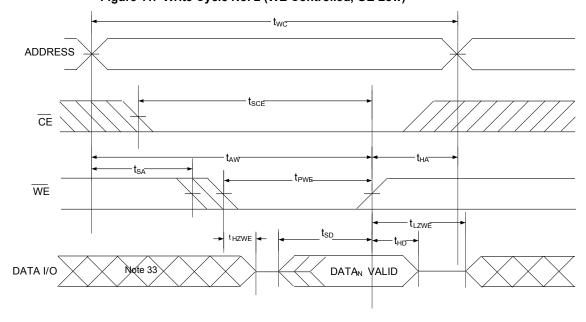


Figure 11. Write Cycle No. 2 (WE Controlled,  $\overline{\text{OE}}$  Low)  $^{[30,\ 31,\ 32,\ 34]}$ 



- 30. For all dual chip enable devices,  $\overline{CE}$  is the logical combination of  $\overline{CE}_1$  and  $\overline{CE}_2$ . When  $\overline{CE}_1$  is LOW and  $\overline{CE}_2$  is HIGH,  $\overline{CE}$  is LOW; when  $\overline{CE}_1$  is HIGH or  $\overline{CE}_2$  is LOW,  $\overline{CE}$  is HIGH.
- 31. The internal write time of the memory is defined by the overlap of  $\overline{WE} = V_{\parallel}$ ,  $\overline{CE} = V_{\parallel}$ . These signals must be LOW to initiate a write, and the HIGH transition of any of these signals can terminate the operation. The input data setup and hold timing should be referenced to the edge of the signal that terminates the write.
- 32. Data I/O is in high impedance state if  $\overline{\text{CE}} = \text{V}_{\text{IH}}$ , or  $\overline{\text{OE}} = \text{V}_{\text{IH}}$ . 33. During this time I/O are in output put state. Do not apply input signals.
- 34. The minimum write cycle width should be sum of  $t_{\text{HZWE}}$  and  $t_{\text{SD}}$ ,



# Truth Table - CY7C1069G/CY7C1069GE

| CE <sub>1</sub>   | CE <sub>2</sub>   | OE                | WE                | I/O <sub>0</sub> -I/O <sub>7</sub> | Mode                       | Power                      |
|-------------------|-------------------|-------------------|-------------------|------------------------------------|----------------------------|----------------------------|
| Н                 | X <sup>[35]</sup> | X <sup>[35]</sup> | X <sup>[35]</sup> | High Z                             | Power-down                 | Standby (I <sub>SB</sub> ) |
| X <sup>[35]</sup> | L                 | X <sup>[35]</sup> | X <sup>[35]</sup> | High Z                             | Power-down                 | Standby (I <sub>SB</sub> ) |
| L                 | Н                 | L                 | Н                 | Data out                           | Read all bits              | Active (I <sub>CC</sub> )  |
| L                 | Н                 | X <sup>[35]</sup> | L                 | Data in                            | Write all bits             | Active (I <sub>CC</sub> )  |
| L                 | Н                 | Н                 | Н                 | High Z                             | Selected, outputs disabled | Active (I <sub>CC</sub> )  |

# ERR Output - CY7C1069GE

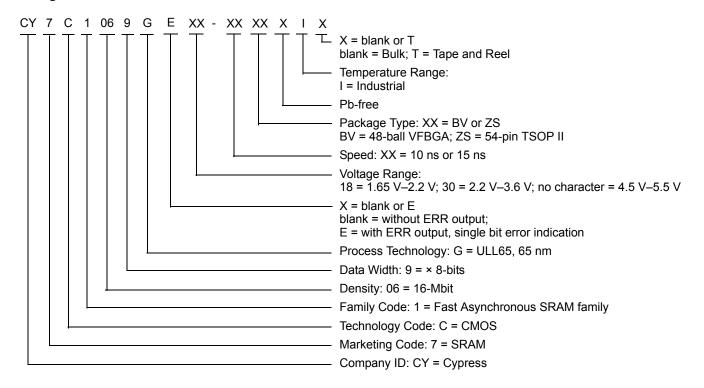
| Output [36]   | Mode   |  |
|---|--|--|
| 0   | 0 Read Operation, no single bit error in the stored data.  |  |
| 1   | 1 Read Operation, single bit error detected and corrected. |  |
| High Z Device deselected or Outputs disabled or Write Operation |  |  |



# **Ordering Information**

| Speed (ns) | Voltage<br>Range | Ordering Code        | Package<br>Diagram | Package Type<br>(All Pb-free) | ERR Pin /<br>Ball | Operating<br>Range |
|------------|------------------|----------------------|--------------------|-------------------------------|-------------------|--------------------|
| 10         | 2.2 V-3.6 V      | CY7C1069G30-10BVXI   | 51-85150           | 48-ball VFBGA                 | No                | Industrial         |
|            |                  | CY7C1069G30-10BVXIT  | 51-85150           | 48-ball VFBGA, Tape and Reel  | No                |                    |
|            |                  | CY7C1069G30-10ZSXI   | 51-85160           | 54-pin TSOP II                | No                |                    |
|            |                  | CY7C1069G30-10ZSXIT  | 51-85160           | 54-pin TSOP II, Tape and Reel | No                |                    |
|            |                  | CY7C1069GE30-10ZSXI  | 51-85160           | 54-pin TSOP II                | Yes               |                    |
|            |                  | CY7C1069GE30-10ZSXIT | 51-85160           | 54-pin TSOP II, Tape and Reel | Yes               |                    |
|            | 4.5 V–5.5 V      | CY7C1069G-10BVXI     | 51-85150           | 48-ball VFBGA                 | No                |                    |
|            |                  | CY7C1069G-10BVXIT    | 51-85150           | 48-ball VFBGA, Tape and Reel  | No                |                    |
|            |                  | CY7C1069G-10ZSXI     | 51-85160           | 54-pin TSOP II                | No                |                    |
|            |                  | CY7C1069G-10ZSXIT    | 51-85160           | 54-pin TSOP II, Tape and Reel | No                |                    |

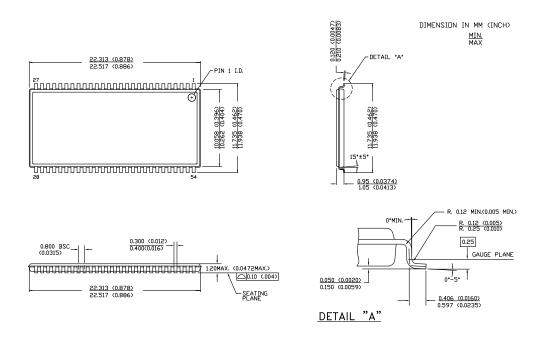
#### **Ordering Code Definitions**





# **Package Diagrams**

Figure 12. 54-pin TSOP II (22.4 × 11.84 × 1.0 mm) Z54-II Package Outline, 51-85160

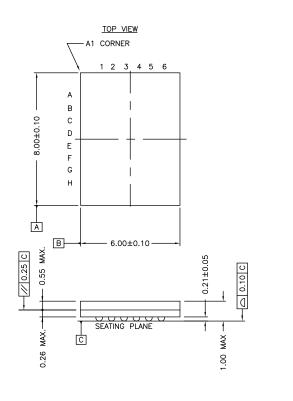


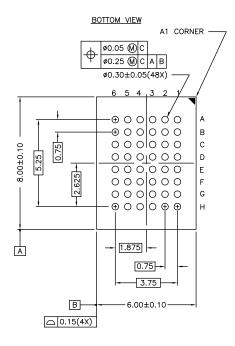
51-85160 \*E



# Package Diagrams (continued)

Figure 13. 48-ball VFBGA (6 × 8 × 1.0 mm) BV48/BZ48 Package Outline, 51-85150





NOTE:
PACKAGE WEIGHT: See Cypress Package Material Declaration Datasheet (PMDD)
posted on the Cypress web.

51-85150 \*H



# **Acronyms**

| Acronym | Description                             |  |  |  |
|---------|---|--|--|--|
| CE      | Chip Enable                             |  |  |  |
| CMOS    | Complementary Metal Oxide Semiconductor |  |  |  |
| I/O     | Input/Output                            |  |  |  |
| ŌĒ      | Output Enable                           |  |  |  |
| SRAM    | Static Random Access Memory             |  |  |  |
| TSOP    | Thin Small Outline Package              |  |  |  |
| TTL     | Transistor-Transistor Logic             |  |  |  |
| VFBGA   | Very Fine-Pitch Ball Grid Array         |  |  |  |
| WE      | Write Enable                            |  |  |  |

# **Document Conventions**

# **Units of Measure**

| Symbol | Unit of Measure |  |  |
|--------|-----------------|--|--|
| °C     | degree Celsius  |  |  |
| MHz    | megahertz       |  |  |
| μΑ     | microampere     |  |  |
| μS     | microsecond     |  |  |
| mA     | milliampere     |  |  |
| mm     | millimeter      |  |  |
| ns     | nanosecond      |  |  |
| Ω      | ohm             |  |  |
| %      | percent         |  |  |
| pF     | picofarad       |  |  |
| V      | volt            |  |  |
| W      | watt            |  |  |



# **Document History Page**

|      | ocument Title: CY7C1069G/CY7C1069GE, 16-Mbit (2M words × 8 bit) Static RAM with Error-Correcting Code (ECC) ocument Number: 001-81539 |                    |                    |   |  |  |
|------|---|--------------------|--------------------|---|--|--|
| Rev. | ECN No.   | Orig. of<br>Change | Submission<br>Date | Description of Change   |  |  |
| *H   | 4800609   | NILE               | 07/31/2015         | Changed status from Preliminary to Final.   |  |  |
| *1   | 5436514   | NILE               |                    | Updated Maximum Ratings: Updated Note 7 (Replaced "2 ns" with "20 ns"). Updated DC Electrical Characteristics: Removed Operating Range "2.7 V to 3.6 V" and all values corresponding to $V_{OH}$ parameter. Included Operating Ranges "2.7 V to 3.0 V" and "3.0 V to 3.6 V" and all values corresponding to $V_{OH}$ parameter. Changed minimum value of $V_{IH}$ parameter from 2.2 V to 2 V corresponding to Operating Range "4.5 V to 5.5 V". Updated Ordering Information: Updated part numbers. Updated to new template. |  |  |
| *J   | 5984763   | AESATMP9           | 12/05/2017         | Updated logo and copyright.   |  |  |



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